



APPLICANT'S ART CITATION

(Use separate sheets if necessary)

Application 10/536,861

OFGS File No. P/2107-277

Applicant Christoph WAGNER et al.

Filing Date July 20, 2005

Group Art Unit 2655

U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)

Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
/M.V./	US-5,777,244	07-1998	Kumagai et al.	73	865.8	
	US-					
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FOREIGN PATENT DOCUMENTS

	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
/M.V./	WO 01/69214	09-2001	PCT	—	—		X

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/M.V./		Search Report dated August 31, 2006.

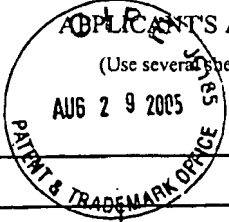
Examiner

/Michael Vanchy Jr/

Date Considered

12/06/2007

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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	US-						
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
/M.V./		International Preliminary Report On Patentability, mailing date July 5, 2005; and attached PCT Notification of Transmittal of Copies of Translation of the International Preliminary Report on Patentability (Chapter I or Chapter II of the Patent Corporation Treaty). Total pages 7.					
Examiner /Michael Vanchy Jr/		Date Considered 12/06/2007					
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JC20 Rec'd PCT/PTO 27 MAY 2005

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Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
/M.V./	US-4,912,336	03-1990	Shree K. Nayar et al	250	559.17	
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	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation Yes No
/M.V./	2000-097641	04-2000	Japan	—	—	
/M.V./	EP 0046241	02-1982	Europe	—	—	
/M.V./	EP 0047936	03-1982	Europe	—	—	
/M.V./	DE 19944354	04-2001	Germany	—	—	Abstract
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
/M.V./		International Search Report for PCT/EP03/13152 dated March 24, 2004				
/M.V./		Lee M-R: "3D Shape Reconstruction of Hybrid Reflectance Using the LMS Algorithm" International Journal of Pattern Recognition and Artificial Intelligence, World Scientific Publishing Company, Singapore, June 2001.				
/M.V./		Lee K M et al: "Shape From Shading With a Generalized Reflectance Map Model" Computer Vision and Image Understanding, Academic Press, August 1997.				
/M.V./		"Shape and Reflectance from an Image Sequence generated using Extended Sources" by Shree K. Nayar et al dated 1989.				
/M.V./		"Determining Shape and Reflectance Properties objects by using Diffuse illumination" by Tae-Eun KIM et al dated 1996.				
/M.V./		"3-D Shape Recovery of Hybrid Reflectance Surface using Indirect Diffuse Illumination" by Tae-Eun KIM et al dated 1995.				
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